

(b)

```

****      small-signal transfer characteristics

v(vout)/iin          = -951.8127
input resistance at   iin          =  47.7102
output resistance at  v(vout)      =  20.6553
    
```

Fig. 1 .tf command results

(c)

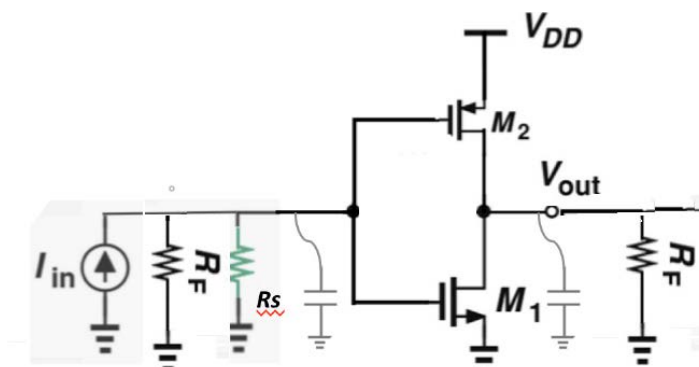
```

**** mosfets

subckt
element  0:m2      0:m1
model    0:p_18.1 0:n_18.1
region   Saturati Saturati
id       -3.2650m 3.2597m
ibs      3.002e-19 -4.831e-19
ibd      7.5096f -9.0565f
vgs      -863.4154m 636.5846m
vds      -858.0495m 641.9505m
vbs      0.      0.
vth      -513.9782m 484.1763m
vdsat    -341.0126m 169.0697m
vod      -349.4372m 152.4084m
beta     51.3762m 223.5379m
gam eff  557.0844m 507.4469m
gm       15.3589m 32.1995m
gds     429.7724u 903.6235u
gmb      4.8331m 5.4728m
cdtot    219.0978f 264.2759f
cgtot    464.8845f 485.0370f
cstot    613.2899f 638.5869f
cbtot    447.1775f 506.9820f
cgs      370.1272f 373.8095f
cgd      71.1546f 71.9082f
    
```

Fig. 2 devices' parameters

First, I calculate open loop gain, input impedance, output impedance. So, I need to break the feedback (i.e. put  $R_F$  at both input and output)





(d)

```
***** pole/zero analysis

input = 0:iin          output = v(vout)

      poles (rad/sec)          poles ( hertz)
real      imag      real      imag
-2.18683g  3.50005g  -348.045x  557.050x
-2.18683g  -3.50005g  -348.045x  -557.050x

      zeros (rad/sec)          zeros ( hertz)
real      imag      real      imag
311.721g  0.         49.6119g   0.

***** constant factor = 52.0074g

***** job concluded
*****
```

Fig. 2 pole/zero analysis results

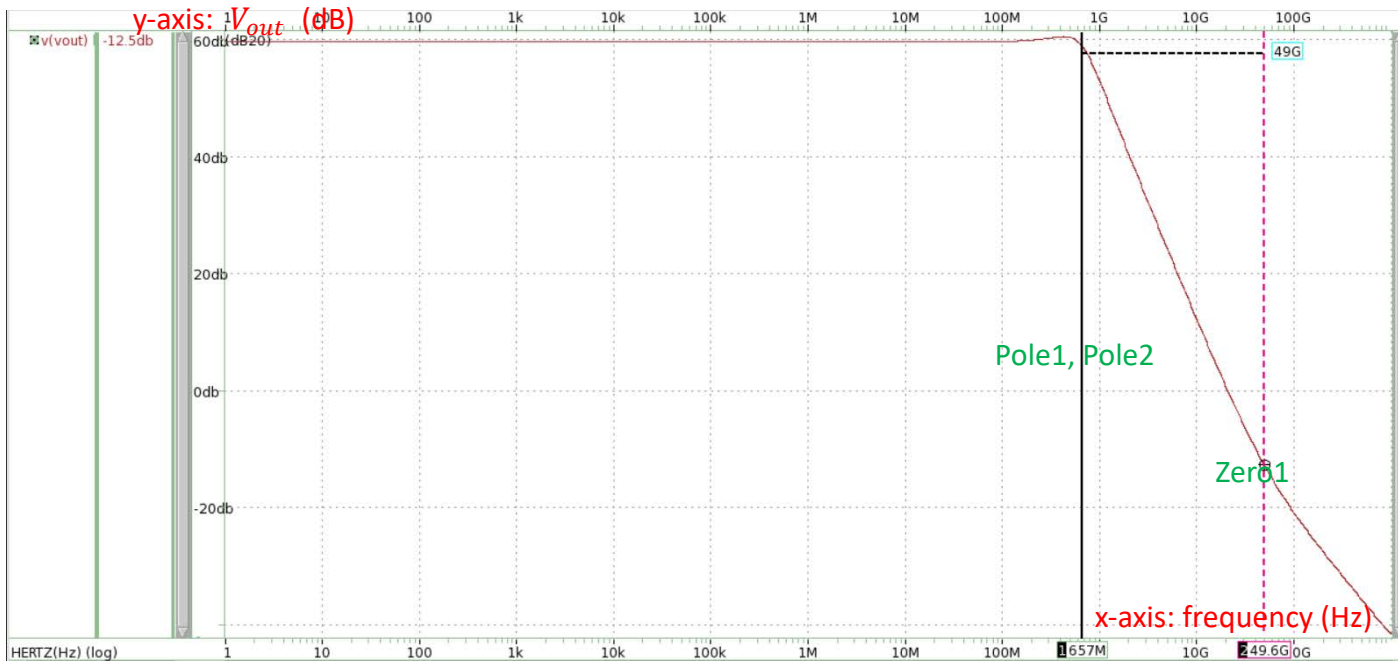


Fig. 3 frequency response

(e)

Consider an amplifier with open-loop transfer function with two real poles

$$A(s) = \frac{A_0}{(1 + \frac{s}{\omega_{p1}})(1 + \frac{s}{\omega_{p2}})}$$

Closed loop poles come from  $1 + A(s)K = 0$

$$\Rightarrow s^2 + s(\omega_{p1} + \omega_{p2}) + (1 + KA_0)\omega_{p1}\omega_{p2} = 0$$

$$\Rightarrow s = \frac{-1}{2}(\omega_{p1} + \omega_{p2}) \pm \frac{1}{2}\sqrt{(\omega_{p1} + \omega_{p2})^2 - 4(1 + KA_0)\omega_{p1}\omega_{p2}}$$

Therefore, I need to calculate open loop poles first.

Use high frequency model of Common source,

$$\frac{V_{out}}{V_{in}} \frac{(C_{GD} - g_m)R}{as^2 + bs + 1}, \text{ where } \left\{ \begin{array}{l} a = (R_S // R_F)R(C_{GS}'C_{GD}' + C_{DB}'C_{GD}' + C_{GS}'C_{DB}') \\ b = (1 + (g_{m1}g + m_2)R)C_{GD}'(R_S // R_F) + (R_S // R_F)C_{GS}' + R(C_{DB}' + C_{GD}') \end{array} \right\}$$

There is a zero (not affected by feedback)

$$w_z = \frac{g_{m1} + g_{m2}}{C_{GD1} + C_{GD2}}, f_z = 52.9 \text{GHz (calculation was done by excel)}$$

gm2	gm1	Cgd1	Cgd2
1.54E-02	3.22E-02	7.19E-14	7.12E-14
zero			
5.29E+10			

There are two poles, supposed  $w_{p2} \gg w_{p1}$  (dominant pole approximation)

$$w_{p1} = \frac{1}{b} = \frac{1}{(1 + (g_{m1}g + m_2)R)C_{GD}'(R_S // R_F) + (R_S // R_F)C_{GS}' + R(C_{DB}' + C_{GD}' )}$$

$$w_{p2} = \frac{b}{a} = \frac{(1 + g_m R)C_{GD}R_S + R_S C_{GS} + R(C_{DB} + C_{GD} + C_L)}{(R_S // R_F)R(C_{GS}'C_{GD}' + C_{DB}'C_{GD}' + C_{GS}'C_{DB}' )}$$

Notation:  $R = R_F // r_{o1} // r_{o2}$

$$C'_{GD} = C_{GD1} + C_{GD2} + C_L$$

$$C'_{GS} = C'_{GS1} + C'_{GS2} + C_L$$

$$C'_{DB} = C_{DB1} + C_{DB2} + C_L$$

Using the value from Fig 5, I can get two poles : (Note:  $C_L = 1.5 \text{pF} \cdot R_S = 5 \text{kohm}$ )

$$f_{p1} = \frac{w_{p1}}{2\pi} = 31.3 \text{MHz}$$

$$f_{p2} = \frac{w_{p2}}{2\pi} = 821 \text{MHz (calculation was done by Excel)}$$

Therefore the **real** part of poles of closed loop =  $\frac{(f_{p1} + f_{p2})}{2} = 426 \text{MHz}$

	Simulation	Hand calculation
zero	49.6119G	52.9G
Pole	348M	426MHz

Poles:

It's quite different from simulation results. I think it's just because the simulation results are mirror poles. But I didn't use the right formula to calculate it, which leads to the big error.

Zero:

Error rate =  $\frac{52.9-49.6119}{52.9} = 6.215\%$ , which is small. The result of hand calculation is very close to the that of simulation as zero is not affected by feedback circuit.

(g)

Gain:

Open loop gain:

$$A = -(g_{m1} + g_{m2})(r_{o1} // r_{o2} // R_F)(R_F // R_S)$$
$$= -\left(\frac{I}{V_{GS1}} + \frac{I}{V_{GS2}}\right) \left(\frac{1}{\lambda I + \lambda I + \frac{1}{R_F}}\right) (R_F // R_S), \text{ assume } R_F \text{ is large, so current of M2 is}$$

equal to current of M1

$$= -\left(\frac{I}{V_{GS1}} + \frac{I}{V_{GS2}}\right) \left(\frac{R_F}{1 + 2\lambda I R_F}\right) (R_F // R_S), \text{ assume } \lambda \text{ of M1, M2 are the same for}$$

the convenience of analysis

$$= -\left(\frac{1}{V_{GS1}} + \frac{1}{V_{GS2}}\right) \left(\frac{1}{2\lambda}\right) (R_F // R_S), \text{ as I have assumed } R_F \text{ is large}$$

$(R_F // R_S)$  is fixed,  $\frac{1}{\lambda} \propto$  (length of MOS),  $V_{S1} = 0, V_{S2} = 1.5$  are fixed as well.  $V_G = I_{in} \times (R_F // R_S)$ .

Closed loop gain:

$$\frac{A}{1+KA} > -950, K = \frac{-1}{R_F}, \text{ thus, A needs to be large enough that closed loop gain } \approx \frac{1}{K},$$

which is  $-1000\Omega$ .

Bandwidth:

$$\text{bandwidth} = (1 + KA_0) \frac{1}{r_o C_L}, r_o = r_{on} // r_{op} // R_F \text{ (open loop, -3dB bandwidth)}$$
$$= \frac{1}{r_o C_L}, r_{on} \ \& \ r_{op} \propto \frac{1}{\text{current of MOS}}, \text{ thus } r_o \propto \text{(current of MOS)}$$

Current:

$$I = 0.5 \times \mu_n \times C_{ox} \times (V_{GS} - V_{th})^2 \times \left(\frac{W}{L}\right) \times [1 + \lambda(V_{DS})]$$

Design flow and result:

As gain needs to be large,  $V_G$  is supposed to as low as possible according to my analysis on gain above. Therefore, I set  $I_{in}$  to a low value as  $V_G = I_{in} \times (R_F // R_S)$ , which is  $1\mu A$ . And I didn't want to let current on MOS get smaller, so what I did was increase aspect ratio  $\left(\frac{W}{L}\right)$ . Also, I could increase length to reach higher gain as

$$\frac{1}{\lambda} \propto \text{(length of MOS)}$$

However, by doing so, bandwidth wouldn't meet the requirement of problem sets, which states bandwidth has to be wider than  $150\text{MHz}$ . I think it's because bandwidth  $\propto$  (current of MOS). Therefore, I only increase length a little bit from  $0.18\mu$  (minimum in

'cic018.l') to 0.3u

According to by my analysis on bandwidth above, it is proportional to current of MOS. And I have increase  $\left(\frac{W}{L}\right)$  to very large  $\frac{99u}{0.3u}$ . Bandwidth has met the requirement of problem sets, but gain hasn't. So I change multiple device from  $m = 1$  to  $m = 2$ . So both of bandwidth and gain have all reached the requirement of problem sets.

Although there are two mosfets to design, for the simplicity of design and analysis, I set the same parameters for both of M1 and M2 (same width, length and multiple device ratio).

Since  $FOM = \left(\frac{Bandwidth}{current}\right)$ , so I made gain as close to -950 as possible or the current would be large. Also, bandwidth has been much higher than 150MHz, I didn't keep increasing  $\left(\frac{W}{L}\right)$  to have better FOM.

## Hspice code

```
.prot
.lib 'cic018.l' TT
.unprot
.option
+post
+accuracy = 1
+captab
.param VDD = 1.5

*MOS
M2 Vout Vg VDD VDD p_18 w = 99u l = 0.3u m = 2
M1 Vout Vg VSS VSS n_18 w = 99u l = 0.3u m = 2
*resistor
Rs Vg VSS 100K
RF Vg Vout 1K
*capacitor
CL_in Vg VSS 1p
CL_out Vout VSS 1p
*current source
```

```
lin VSS Vg DC 1u AC 1 $DC = 1u
```

```
v1 VDD gnd VDD
```

```
v2 VSS gnd 0
```

```
.DC lin 1u 20u 0.1u
```

```
.AC DEC 1k 1 1T
```

```
.probe AC
```

```
+ c_db_2 = LX29(M2)
```

```
+ c_db_1 = LX29(M1)
```

```
+gain = par('V(Vout)/I(lin)')
```

```
.pz V(vout) lin
```

```
.tf V(Vout) lin
```

```
.op
```

```
.END
```